

NP08N60CF-VB Datasheet N-Channel 650V (D-S) Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	650			
R _{DS(on)} at 25 °C (Ω)	$V_{GS} = 10 V$	0.82		
Q _g max. (nC)	57			
Q _{gs} (nC)	4.0			
Q _{gd} (nC)	5.4			
Configuration	Single			

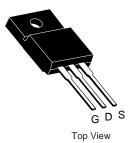
FEATURES

- Low figure-of-merit (FOM) $R_{on} \ge Q_g$
- Low input capacitance (C_{iss})
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_g)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
- Fluorescent ballast lighting
- Industrial

TO-220 FULLPAK



G C S N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted) SYMBOL PARAMETER LIMIT UNIT Drain-Source Voltage 650 V_{DS} V ± 30 Gate-Source Voltage V_{GS} T_C = 25 °C 10 Continuous Drain Current (T_{.1} = 150 °C) V_{GS} at 10 V I_{D} T_C = 100 °C 8 А Pulsed Drain Current a I_{DM} 35 1.67/1.5/0.3 Linear Derating Factor W/°C Single Pulse Avalanche Energy b E_{AS} 86 mJ Maximum Power Dissipation 178/156/53 W P_D Operating Junction and Storage Temperature Range -55 to +150 °C T_J, T_{stq} Drain-Source Voltage Slope T_J = 125 °C 50 dV/dt V/ns Reverse Diode dV/dt d 4.5 Soldering Recommendations (Peak Temperature) ^c °C for 10 s 300

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 28.2 mH, $R_g = 25 \Omega$, $I_{AS} = 3.5$ A.

c. 1.6 mm from case. d. $I_{SD} \leq I_D$, dI/dt = 100 A/µs, starting T_J = 25 °C.



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	63	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.6	0/10

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				•	•		•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, $I_D = 1 \text{ mA}$ -		0.65	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$		2	-	4	V
		$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 30 \text{ V}$		-	-	± 1	μA
		$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	1	
Zero Gate Voltage Drain Current	I _{DSS}		∕, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 4 A$	-	0.82	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D = 4 A	-	16	-	S
Dynamic				1	1	1	1
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 100 V,		-	1900	-	-
Output Capacitance	C _{oss}			-	400	-	
Reverse Transfer Capacitance	C _{rss}		f = 1 MHz	-	240	-	1
Effective Output Capacitance, Energy Related ^a	C _{o(er)}			-	45	-	pF
Effective Output Capacitance, Time Related ^b	C _{o(tr)}	$ V_{DS} = 0$ V	V to 520 V, V _{GS} = 0 V	-	62	-	
Total Gate Charge	Qg			-	40	57	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	$I_D = 4 \text{ A}, V_{DS} = 520 \text{ V}$	-	4.0	-	nC
Gate-Drain Charge	Q _{gd}			-	5.4	-	
Turn-On Delay Time	t _{d(on)}			-	25	-	
Rise Time	t _r	$\begin{array}{c c} & - & 25 \\ \hline V_{DD} = 520 \text{ V}, \text{ I}_{D} = 4 \text{ A}, \\ V_{GS} = 10 \text{ V}, \text{ R}_{g} = 9.1 \Omega \\ \hline & - & 70 \\ \hline & - & 40 \end{array}$		55	-	1	
Turn-Off Delay Time	t _{d(off)}			-	ns		
Fall Time	t _f			-	40	-	1
Gate Input Resistance	Rg	f = 1	MHz, open drain	-	3.5	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	7	
Pulsed Diode Forward Current	I _{SM}	integral revers p - n junction		-	-	18	A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 4 A, V _{GS} = 0 V		-	-	1.5	V
Reverse Recovery Time	t _{rr}			-	190	-	ns
Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 4 \text{ A},$		-	μC		
Reverse Recovery Current	I _{RRM}	ai/dt =	100 A/µs, V _R = 400 V	_	10	_	A

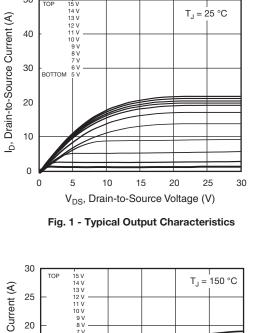
Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

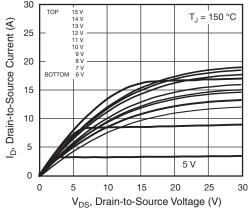


Fig. 2 - Typical Output Characteristics

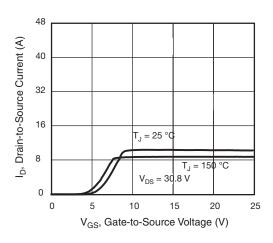


Fig. 3 - Typical Transfer Characteristics

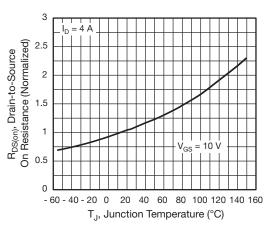


Fig. 4 - Normalized On-Resistance vs. Temperature

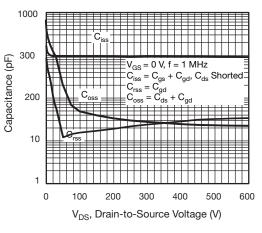


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

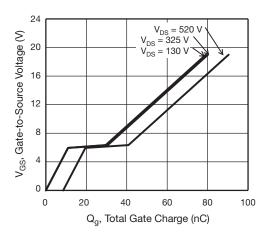


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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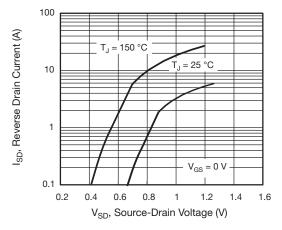


Fig. 7 - Typical Source-Drain Diode Forward Voltage

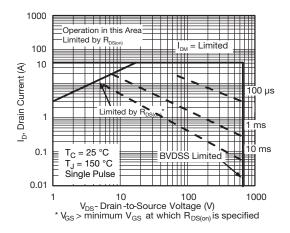


Fig. 8 - Maximum Safe Operating Area

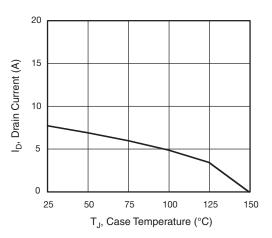


Fig. 9 - Maximum Drain Current vs. Case Temperature

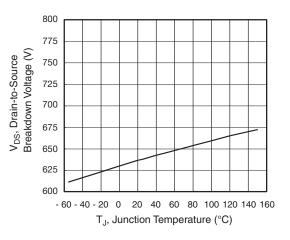


Fig. 10 - Temperature vs. Drain-to-Source Voltage

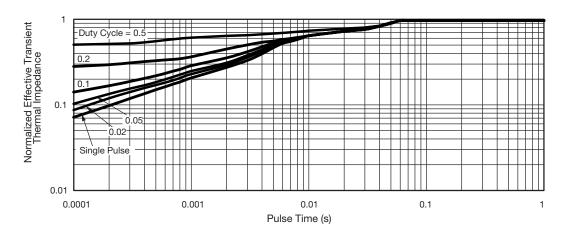


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



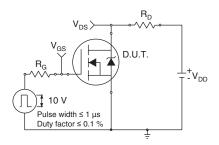


Fig. 12 - Switching Time Test Circuit

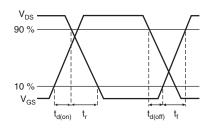


Fig. 13 - Switching Time Waveforms

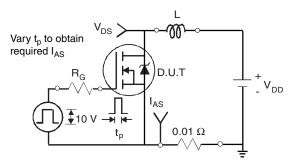


Fig. 14 - Unclamped Inductive Test Circuit

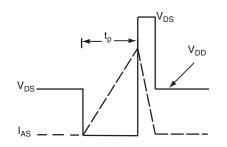


Fig. 15 - Unclamped Inductive Waveforms

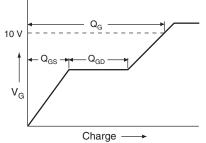


Fig. 16 - Basic Gate Charge Waveform

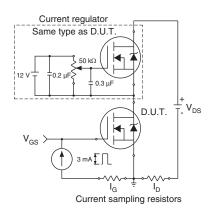
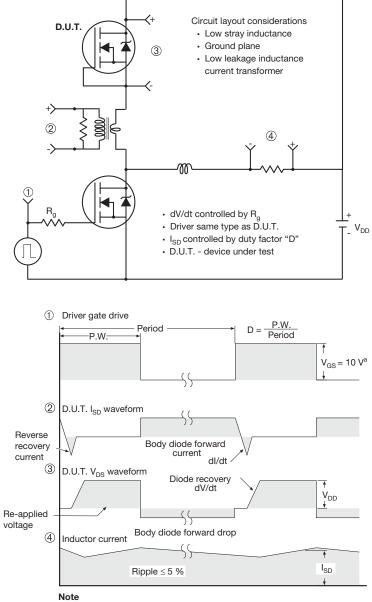


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

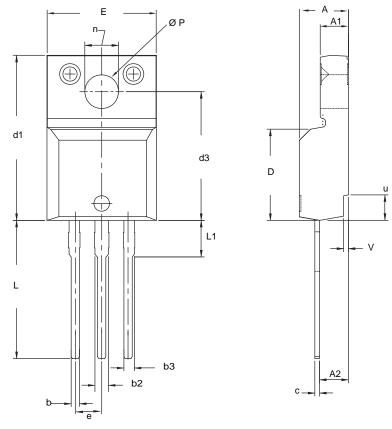


a. $V_{GS} = 5 V$ for logic level devices

Fig. 18 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
А	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
C	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54 BSC		0.100 BSC	
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
Ø P	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

Notes

Notes 1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness. 5. No chipping or package damage.

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